

- Logic Level
- Advanced Process Technology
- Optimized for Automotive DC-DC, Motor Drive and other Heavy Load Applications
- Exceptionally Small Footprint and Low Profile
- High Power Density
- Low Parasitic Parameters
- Dual Sided Cooling
- 175°C Operating Temperature
- Repetitive Avalanche Capability for Robustness and Reliability

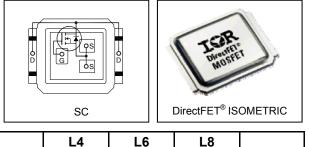
Applicable DirectFET<sup>®</sup> Outline and Substrate Outline ①

- Lead free, RoHS and Halogen free
- Automotive Qualified \*

SC

V <sub>(BR)DSS</sub>	40V
R <sub>DS(on)</sub> typ.	<b>5.0m</b> Ω
max.	6.6mΩ
D (Silicon Limited)	58A
<b>Q</b> <sub>g (typical)</sub>	22nC

Automotive DirectFET<sup>®</sup> Power MOSFET ②



#### Description

SB

The AUIRL7732S2 combines the latest Automotive HEXFET® Power MOSFET Silicon technology with the advanced DirectFET® packaging to achieve low gate charge as well as the lowest on-state resistance in a package that has the footprint which is 38% smaller than an SO-8 and only 0.7mm profile. The DirectFET® package is compatible with existing layout geometries used in power applications, PCB assembly equipment and vapor phase, infra-red or convection soldering techniques, when application note AN-1035 is followed regarding the manufacturing methods and processes. The DirectFET® package allows dual sided cooling to maximize thermal transfer in automotive power systems.

M4

M2

This HEXFET® Power MOSFET is designed for applications where efficiency and power density are of value. The advanced DirectFET® packaging platform coupled with the latest silicon technology allows the AUIRL7732S2 to offer substantial system level savings and performance improvement specifically in high frequency DC-DC, motor drive and other heavy load applications on ICE, HEV and EV platforms. The AUIRL7732S2 can be utilized together with the AUIRL7736M2 as a control/sync MOSFET pair in a buck converter topology. This MOSFET utilizes the latest processing techniques to achieve low on-resistance and low Qg per silicon area. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for high current automotive applications.

Base Part Number Package Type		Standard	Orderable Part Number	
base Part Number	Package Type	Form	Quantity	Orderable Part Number
AUIRL7732S2	DirectFET Small Can	Tape and Reel	4800	AUIRL7732S2TR

#### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
V <sub>DS</sub>	Drain-to-Source Voltage	40	V
V <sub>GS</sub>	Gate-to-Source Voltage	±16	v
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) ④	58	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) ④	<u>۹</u> 41	
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited) 3	14	A
I <sub>DM</sub>	Pulsed Drain Current ©	230	
P <sub>D</sub> @T <sub>C</sub> = 25°C	Power Dissipation ④	41	14/
P <sub>D</sub> @T <sub>A</sub> = 25°C			W
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 6	46	
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy 6	124	mJ
I <sub>AR</sub>	Avalanche Current ©		А
E <sub>AR</sub>	Repetitive Avalanche Energy S	See Fig. 16, 17, 18a, 18b	mJ
T <sub>P</sub>	Peak Soldering Temperature	260	
TJ	Operating Junction and	-55 to + 175	°C
T <sub>STG</sub>	Storage Temperature Range		

HEXFET® is a registered trademark of Infineon.

\*Qualification standards can be found at www.infineon.com

# **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ ext{ heta}JA}$	Junction-to-Ambient ③		67	
$R_{ ext{ heta}JA}$	Junction-to-Ambient ®	12.5		
$R_{ ext{ heta}JA}$	Junction-to-Ambient	20		°C/W
$R_{ ext{ hetaJ-Can}}$	Junction-to-Can @ ®		3.7	
$R_{ ext{ heta}J ext{-PCB}}$	Junction-to-PCB Mounted	1.0		
	Linear Derating Factor ④	0	.27	W/°C

# Static Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	40			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.03		V/°C	Reference to 25°C, $I_D$ = 1.0mA
D Ctatia Durain ta Cauraa On Dagiatanga			5.0	6.6		V <sub>GS</sub> = 10V, I <sub>D</sub> = 35A ⊘
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		7.5	10.5	mΩ	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 29A ⊘
V <sub>GS(th)</sub>	Gate Threshold Voltage	1.0	1.8	2.5	V	
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Coefficient		-7.1		mV/°C	$V_{DS}$ = $V_{GS}$ , $I_D$ = 50 $\mu$ A
gfs	Forward Transconductance	64			S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 35A
R <sub>G</sub>	Internal Gate Resistance		0.64		Ω	
	Drain to Course Lookana Current			5.0		$V_{DS} = 40V, V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			250	μA	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100		V <sub>GS</sub> = 16V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -16V

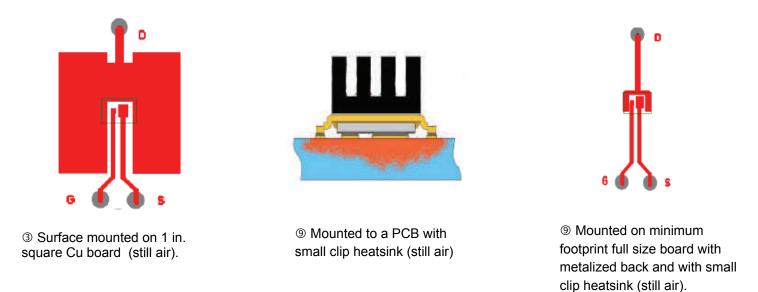
Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q <sub>g</sub>	Total Gate Charge		22	33		V <sub>DS</sub> = 20V
Q <sub>gs1</sub>	Gate-to-Source Charge		3.3			V <sub>GS</sub> = 4.5V
Q <sub>gs2</sub>	Gate-to-Source Charge		2.8			I <sub>D</sub> = 35A
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge		13		nC	See Fig. 11
Q <sub>godr</sub>	Gate Charge Overdrive		2.9			
Q <sub>sw</sub>	Switch Charge (Q <sub>gs2</sub> + Q <sub>gd</sub> )		15.8			
Q <sub>oss</sub>	Output Charge		13		nC	$V_{DS} = 16V, V_{GS} = 0V$
t <sub>d(on)</sub>	Turn-On Delay Time		21			V <sub>DD</sub> = 20V
t <sub>r</sub>	Rise Time		123			I <sub>D</sub> = 35A
t <sub>d(off)</sub>	Turn-Off Delay Time		22		ns	$R_{G} = 6.8\Omega$
t <sub>f</sub>	Fall Time		37			V <sub>GS</sub> = 4.5V ⑦
C <sub>iss</sub>	Input Capacitance		2020			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		410			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		210			f = 1.0 MHz
C <sub>oss</sub>	Output Capacitance		1460		pF	$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0 \text{ MHz}$
C <sub>oss</sub>	Output Capacitance		365			$V_{GS} = 0V, V_{DS} = 32V, f = 1.0 \text{ MHz}$
C <sub>oss</sub>	Output Capacitance		630			$V_{GS} = 0V, V_{DS} = 0 \text{ to } 32V$



## **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			58		MOSFET symbol
IS	(Body Diode)			50	^	showing the
1	Pulsed Source Current			220	A	integral reverse
I <sub>SM</sub>	(Body Diode) <sup>⑤</sup>			230		p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$T_J$ = 25°C, $I_S$ = 35A, $V_{GS}$ = 0V $\odot$
t <sub>rr</sub>	Reverse Recovery Time		23	35	ns	T <sub>J</sub> = 25°C, I <sub>F</sub> = 35A, V <sub>DD</sub> = 20V
Q <sub>rr</sub>	Reverse Recovery Charge		16	24	nC	dv/dt = 100A/µs ⊘



- 0 Click on this section to link to the appropriate technical paper. 0 Click on this section to link to the DirectFET Website.
- ③ Surface mounted on 1 in. square Cu board, steady state.
- ④ T<sub>c</sub> measured with thermocouple mounted to top (Drain) of part.
- © Repetitive rating; pulse width limited by max. junction temperature.
- 6 Starting T<sub>J</sub> = 25°C, L = 0.075mH, R<sub>G</sub> = 50Ω, I<sub>AS</sub> = 35A.
- $\bigcirc$  Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- <sup>®</sup> Used double sided cooling, mounting pad with large heat sink.
- Mounted on minimum footprint full size board with metalized back and with small clip heat sink.
- **(1)**  $R_{\theta}$  is measured at T<sub>J</sub> of approximately 90°C.



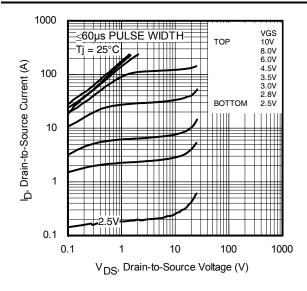


Fig. 1 Typical Output Characteristics

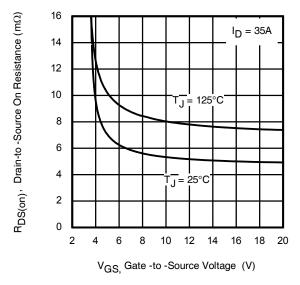


Fig. 3 Typical On-Resistance vs. Gate Voltage

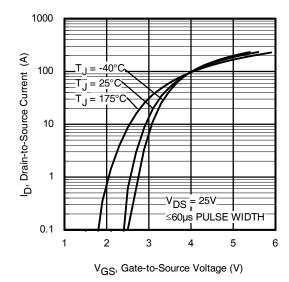


Fig 5. Transfer Characteristics

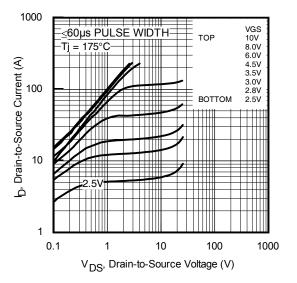


Fig. 2 Typical Output Characteristics

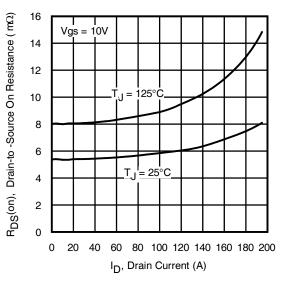


Fig. 4 Typical On-Resistance vs. Drain Current

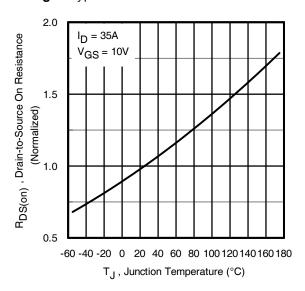
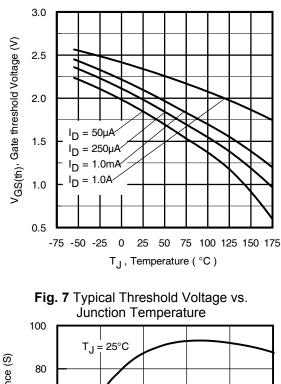


Fig 6. Normalized On-Resistance vs. Temperature





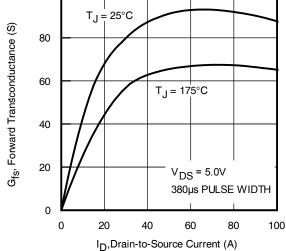


Fig 9. Typical Forward Trans conductance vs. Drain Current

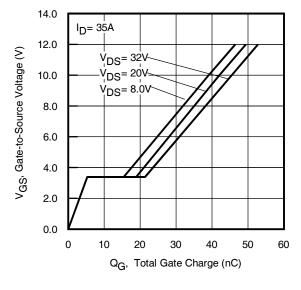
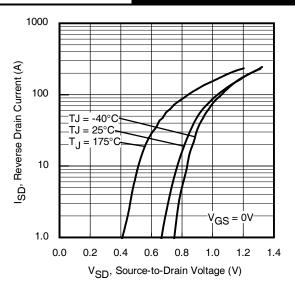
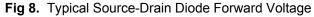
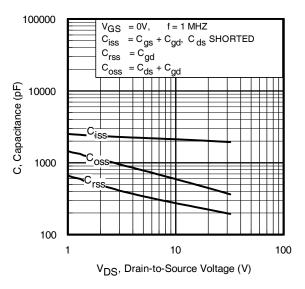
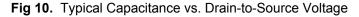


Fig 11. Typical Gate Charge vs. Gate-to-Source Voltage









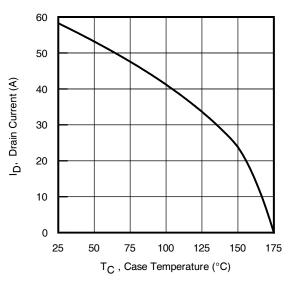
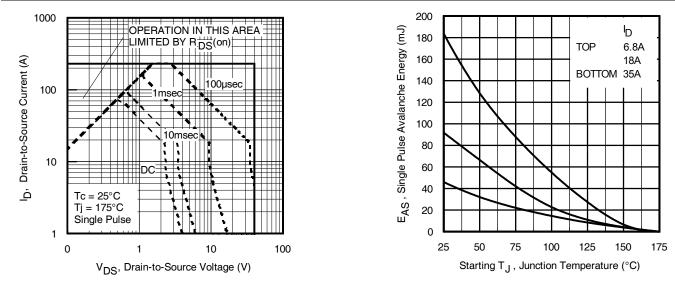


Fig 12. Maximum Drain Current vs. Case Temperature





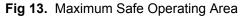


Fig 14. Maximum Avalanche Energy vs. Temperature

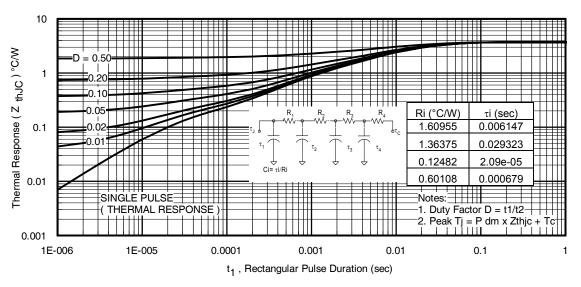


Fig 15. Maximum Effective Transient Thermal Impedance, Junction-to-Case

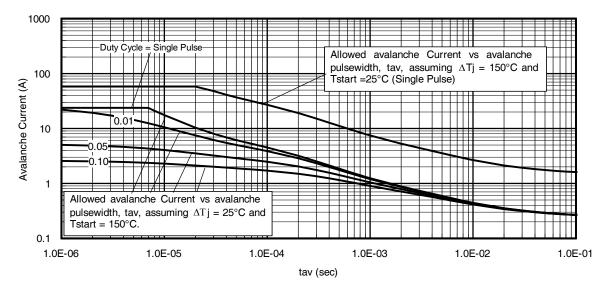
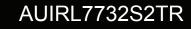
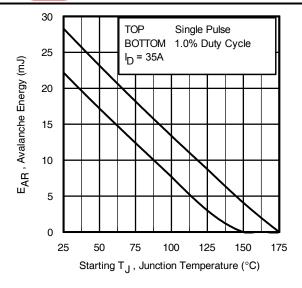
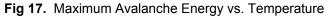


Fig 16. Typical Avalanche Current vs. Pulse Width









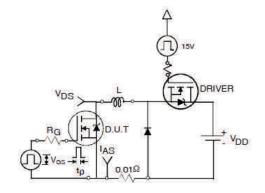


Fig 18a. Unclamped Inductive Test Circuit

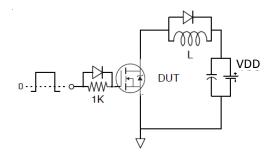


Fig 19a. Gate Charge Test Circuit

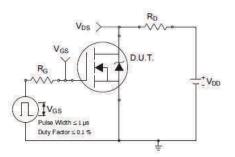
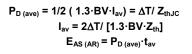
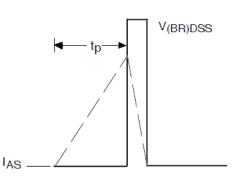


Fig 20a. Switching Time Test Circuit

# Notes on Repetitive Avalanche Curves , Figures 16, 17:

- (For further info, see AN-1005 at www.infineon.com)
- 1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in
  - excess of T<sub>jmax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 16, 17).
  - tav = Average time in avalanche.
  - D = Duty cycle in avalanche =  $t_{av} \cdot f$
  - ZthJC(D, tav) = Transient thermal resistance, see Figures 15)





## Fig 18b. Unclamped Inductive Waveforms

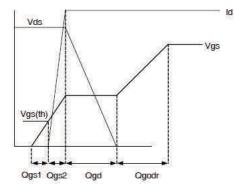


Fig 19b. Gate Charge Waveform

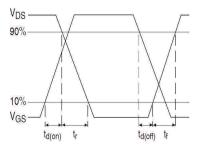
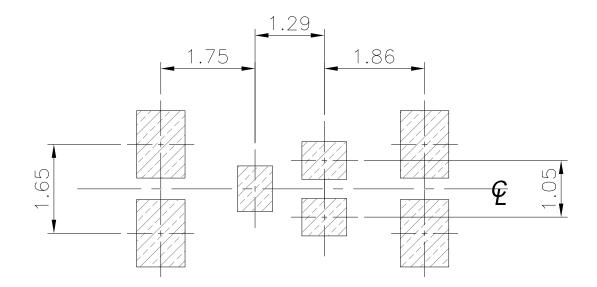
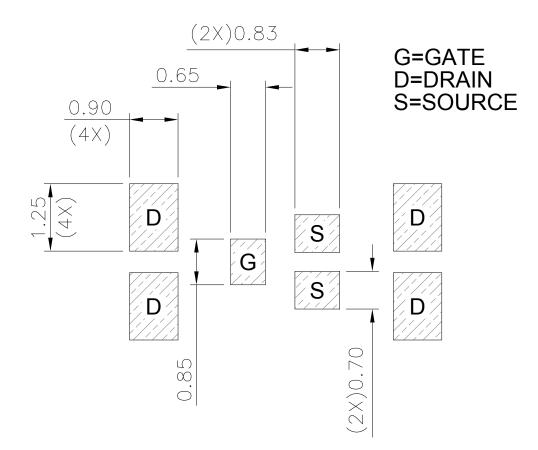


Fig 20b. Switching Time Waveforms



**DirectFET**<sup>®</sup> **Board Footprint, SC (Small Size Can).** Please see DirectFET<sup>®</sup> application note AN-1035 for all details regarding the assembly of DirectFET<sup>®</sup>. This includes all recommendations for stencil and substrate designs.



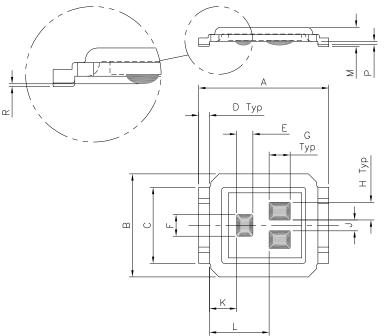


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



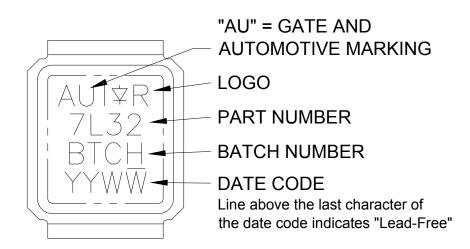
# DirectFET<sup>®</sup> Outline Dimension, SC Outline (Small Size Can).

Please see DirectFET<sup>®</sup> application note AN-1035 for all details regarding the assembly of DirectFET<sup>®</sup>. This includes all recommendations for stencil and substrate designs.



	DIMENSIONS				
	METRIC		IMPE	RIAL	
CODE	MIN	MAX	MIN	MAX	
Α	4.75	4.85	0.187	0.191	
В	3.70	3.95	0.146	0.156	
С	2.75	2.85	0.108	0.112	
D	0.35	0.45	0.014	0.018	
E	0.58	0.62	0.023	0.024	
F	0.78	0.82	0.031	0.032	
G	0.75	0.80	0.030	0.031	
Н	0.63	0.67	0.025	0.026	
J	0.38	0.42	0.015	0.016	
K	0.95	1.05	0.037	0.041	
L	2.15	2.25	0.085	0.088	
М	0.68	0.74	0.027	0.029	
Р	0.08	0.17	0.003	0.007	
R	0.02	0.08	0.001	0.003	

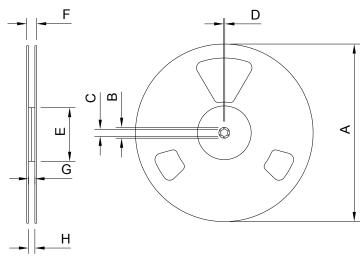
DirectFET<sup>®</sup> Part Marking



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

# DirectFET<sup>®</sup> Tape & Reel Dimension (Showing component orientation)

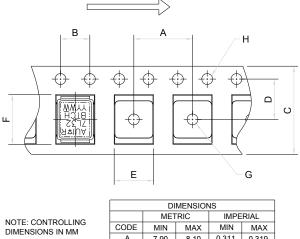
infineon



NOTE: Controlling dimensions in mm Std reel quantity is 4800 parts, ordered as AUIRL7732S2TR.

REEL DIMENSIONS				
	STANDA	RD OPTI	DNQTY 4	800)
	М	ETRIC	IMF	PERIAL
CODE	MIN	MAX	MIN	MAX
Α	330.0	N.C	12.992	N.C
В	20.2	N.C	0.795	N.C
С	12.8	13.2	0.504	0.520
D	1.5	N.C	0.059	N.C
E	100.0	N.C	3.937	N.C
F	N.C	18.4	N.C	0.724
G	12.4	14.4	0.488	0.567
Н	11.9	15.4	0.469	0.606

LOADED TAPE FEED DIRECTION



		MET	METRIC		RIAL
DLLING MM	CODE	MIN	MAX	MIN	MAX
	A	7.90	8.10	0.311	0.319
	В	3.90	4.10	0.154	0.161
	С	11.90	12.30	0.469	0.484
	D	5.45	5.55	0.215	0.219
	E	4.00	4.20	0.158	0.165
	F	5.00	5.20	0.197	0.205
	G	1.50	N.C	0.059	N.C
	Н	1.50	1.60	0.059	0.063

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

## **Qualification Information**

		Automotive (per AEC-Q101)		
Qualificat	tion Level	Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.		
Moisture	Sensitivity Level	DFET2 Small Can	MSL1	
	Machine Model	Class M4 ( +/-425V) <sup>†</sup>		
		AEC-Q101-002		
	Liumen Dedy Medel	Class H1B (+/-1000V) <sup>†</sup>		
ESD	Human Body Model	AEC-Q101-001		
Charged Device Model		N/A		
		AEC-Q101-005		
RoHS Cor	mpliant	Y	/es	

† Highest passing voltage.

## **Revision History**

Date	Comments
12/11/2015	<ul> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> <li>Updated Tape and Reel option on page 10</li> </ul>

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